



Low-Power 12-Output ZDB / Fanout Clock Buffer for PCIe 5.0 and UPI

Description

The DIODES[™] PI6CBE33125 is a low-power PCIe[®] 1.0/2.0/3.0/ 4.0/5.0 clock buffer. It takes a reference input to fanout twelve 100MHz low-power differential HCSL outputs with on-chip terminations for 85Ω output impedance. It supports both zero-delay and fanout buffer functions for various applications. An individual OE pin for each output provides easier power management. It uses Diodes proprietary PLL design to achieve very-low jitter that meets PCIe 1.0/2.0/3.0/4.0/5.0 requirements. Other than PCIe 100MHz support, this device also supports 133.33MHz via a pin.

Block Diagram



Features

- Twelve Differential Low-Power HCSL Outputs with On-Chip Termination
- Default $Z_{OUT} = 85\Omega$
- Spread Spectrum Tolerant ٠
- Individual Output Enable •
- Selectable PLL Bandwidths
- Hardware/SMBus Control of ZDB and Fanout Buffer Modes
- Up to 9 Selectable SMBus Addresses
- 1 to 400MHz Fanout Buffer Operation •
- 100MHz and 133.33MHz ZDB Mode
- Differential Output-to-output Skew <50ps
- Very Low Jitter Outputs
 - Differential Cycle-to-cycle Jitter <50ps
 - Fanout Buffer Mode Additive Phase Jitter
 - PCIe 5.0 CC: 0.0074 ps
 - DB2000Q Additive Jitter: 0.02ps
 - ZDB Mode Phase Jitter
 - PCIe 5.0 CC: RMS 0.02 ps
 - QPI/UPI 11.4GB/s: 0.14ps RMS
 - IF-UPI: RMS 0.15 ps
- 3.3V Core Supply Voltage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/104/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.

https://www.diodes.com/quality/product-definitions/

- Packaging (Pb-free & Green):
 - 64-lead, 9mm × 9mm TQFN (ZD)

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.





Pin Configuration



Pin Description

Pin Number	Pin Name	Туре		Description			
1	VDDA	Power	_	Analog VDD			
2	GNDA	Power		Analog ground			
3	NC	—	_	Internal connected for feedback loop. Do not connect this pin.			
4	100M_133M#	Input	CMOS	Latch to select frequency. This pin has internal pullup resistor. See F quency Select Table			
5	BW_SEL_TRI	Input	Tri-level	Latch to select low-loop bandwidth, bypass PLL, and high-loop band- width. This pin has internal pullup resistor			
6	PD#	Input	CMOS	Input notifies device to sample latched inputs and start up on first high assertion. Low enters Power Down Mode; subsequent high assertions exit Power Down Mode. This pin has internal pullup resistor.			
7	GNDR	Power		Analog ground for receiver			





Pin Number	Pin Name	Ту	pe	Description		
8	VDDR	Power	_	Analog VDD for receiver		
9	IN+	Input	HCSL	Differential true clock input		
10	IN-	Input	HCSL	Differential complementary clock input		
11	SADR0_TRI	Input	Tri-level	Latch to select SMBus Address. This pin has an internal pulldown.		
12	SDATA	Input/ Output	CMOS	SMBUS Data line, 3.3V tolerant		
13	SCLK	Input	CMOS	SMBUS clock input, 3.3V tolerant		
14	SADR1_TRI	Input	Tri-level	Latch to select SMBus Address. This pin has an internal pulldown.		
15	FBOUT_NC-	_	_	Complementary differential feedback output. This pin should NOT b connected to anything outside the chip. It exists to provide delay path matching to get zero propagation delay.		
16	FBOUT_NC+	_	_	True differential feedback output. This pin should NOT be connected anything outside the chip. It exists to provide delay path matching to zero propagation delay.		
17	Q0+	Output	HCSL	Differential true clock output		
18	Q0-	Output	HCSL	Differential complementary clock output		
19	OE0#	Input	CMOS	Active low input for enabling Q0 pair. This pin has an internal pulldown. 1 =disable outputs, 0 = enable outputs		
20	OE1#	Input	CMOS	1 =disable outputs, 0 = enable outputs		
21	Q1+	Output	HCSL	Differential true clock output		
22	Q1-	Output	HCSL	Differential complementary clock output		
23, 33, 41, 48, 58	GND	Power		Ground		
24, 40, 57	V _{DD}	Power	_	Power supply, nominal 3.3V		
25, 32, 49, 56	VDDO	Power	_	Power supply for differential outputs		
26	Q2+	Output	HCSL	Differential true clock output		
27	Q2-	Output	HCSL	Differential complementary clock output		
28	OE2#	Input	CMOS	Active low input for enabling Q2 pair. This pin has an internal pulldown. 1 =disable outputs, 0 = enable outputs		
29	OE3#	Input	CMOS	Active low input for enabling Q3 pair. This pin has an internal pulldown. 1 =disable outputs, 0 = enable outputs		
30	Q3+	Output	HCSL	Differential true clock output		
31	Q3-	Output	HCSL	Differential complementary clock output		
34	Q4+	Output	HCSL	Differential true clock output		
35	Q4-	Output	HCSL	Differential complementary clock output		
36	OE4#	Input	CMOS	Active low input for enabling Q4 pair. This pin has an internal pulldown. 1 =disable outputs, 0 = enable outputs		





Pin Number	Pin Name	Ту	ре	Description	
37	OE5#	Input	CMOS	Active low input for enabling Q5 pair. This pin has an internal pulldown. 1 =disable outputs, 0 = enable outputs	
38	Q5+	Output	HCSL	Differential true clock output	
39	Q5-	Output	HCSL	Differential complementary clock output	
42	Q6+	Output	HCSL	Differential true clock output	
43	Q6-	Output	HCSL	Differential complementary clock output	
44	OE6#	Input	CMOS	Active low input for enabling Q6 pair. This pin has an internal pulld 1 =disable outputs, 0 = enable outputs	
45	OE7#	Input	CMOS	Active low input for enabling Q7 pair. This pin has an internal pulldown. 1 =disable outputs, 0 = enable outputs	
46	Q7+	Output	HCSL	Differential true clock output	
47	Q7-	Output	HCSL	Differential complementary clock output	
50	Q8+	Output	HCSL	Differential true clock output	
51	Q8-	Output	HCSL	SL Differential complementary clock output	
52	OE8#	Input	CMOS	MOS Active low input for enabling Q8 pair. This pin has an internal pulldor 1 =disable outputs, 0 = enable outputs	
53	OE9#	Input	CMOS	1 = disable outputs, $0 =$ enable outputs Active low input for enabling O9 pair. This pin has an internal pulldow	
54	Q9+	Output	HCSL	Differential true clock output	
55	Q9-	Output	HCSL	Differential complementary clock output	
59	Q10+	Output	HCSL	Differential true clock output	
60	Q10-	Output	HCSL	Differential complementary clock output	
61	OE10#	Input	CMOS	Active low input for enabling Q10 pair. This pin has an internal pull- down. 1 =disable outputs, 0 = enable outputs	
62	OE11#	Input	CMOS	Active low input for enabling Q11 pair. This pin has an internal pull- down. 1 = disable outputs, 0 = enable outputs	
63	Q11+	Output	HCSL	Differential true clock output	
64	Q11-	Output	HCSL	Differential complementary clock output	
EPAD	EPAD	Power		Connect to ground	





SMBus Address Selection Table

	SADR1_tri	SADR0_tri	Address
State of SADR on first application of PD#	0	0	D8
	0	М	DA
	0	1	DE
	М	0	C2
	М	М	C4
	М	1	C6
	1	0	CA
	1	М	CC
	1	1	CE

Power Management Table

PD#	IN	SMBus OE bit	OEn#	Qn+	Qn-	PLL Status
0	Х	Х	Х	Low	Low	Off
1	Running	0	Х	Low	Low	On ⁽¹⁾
1	Running	1	0	Running	Running	On ⁽¹⁾
1	Running	1	1	Low	Low	On ⁽¹⁾

Note:

1. If PLL Bypass mode is selected, the PLL will be off and outputs will be running.

PLL Operating Mode Select Table

BW_SEL_TRI	Operating Mode	PLL
0	PLL with Low Bandwidth	Running
М	PLL Bypass	Off
1	PLL with High Bandwidth	Running

Frequency Select Table

100M_133M#	IN (MHz)	Qn (MHz)
0	133.33	133.33
1 (default)	100	100





Maximum Ratings

Supply Voltage to Ground Potential, VDDxx-0.5V to +4.6VRATINGS may causeInput Voltage-0.5V to VDD +0.5V, not exceed 4.6VThis is a stress ratingSMBus, Input High Voltage3.6Vindicated in the operatESD Protection (HBM)2000Vin timplied. Expose	those listed under MAXIMUM permanent damage to the device. only and functional operation of my other conditions above those onal sections of this specification are to absolute maximum rating d periods may affect reliability.

Operating Conditions

Temperature = T_A ; Supply voltages per norma	l operation conditions; See test circuits for the load conditions	;
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Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
V _{DD} , V _{DDA} , V _{DDR}	Power Supply Voltage	_	3.135	3.3	3.465	V
V _{DDO}	Output Power Supply Voltage		0.95	1.05-3.3	3.465	V
I _{DDA}	Analog Power Supply Current	V _{DDA} , PLL mode, All outputs active @ 100MHz	_	20	25	mA
I _{DD}	Power Supply Current	$V_{DD} + V_{DD_R}$, All outputs active @ 100MHz	_	46	55	mA
I _{DDO}	Power Supply Current for Outputs ⁽²⁾	V _{DDO} , PLL mode, All outputs active @ 100MHz	_	90	110	mA
I _{DDA_PD}	Analog Power Supply Power Down ⁽¹⁾ Current	V _{DDA} , PLL mode, All outputs LOW/LOW	_	0.55	1	mA
I _{DD_PD}	Power Supply Power Down ⁽¹⁾ Current	$V_{DD +} V_{DD_R}$, All outputs LOW/LOW	_	0.9	1.1	mA
I _{DDO_PD}	Power Supply Current Power Down ⁽¹⁾ for Outputs	V _{DDO} , All outputs LOW/LOW	_	1.75	2.5	mA
T _A	Ambient Temperature	Industrial grade	-40	_	85	°C

Note:

1. Input clock is not running.

2. Outputs drive 10 inch trace.

Input Electrical Characteristics

Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
R _{pu}	Internal Pullup Resistance	_	_	120		KΩ
R _{dn}	Internal Pulldown Resistance	_	_	120		KΩ
L _{PIN}	Pin Inductance	—	_	_	7	nH



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SMBus Electrical Characteristics

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Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
V _{DDSMB}	Nominal Bus Voltage	—	2.7	_	3.6	V
		SMBus, $V_{DDSMB} = 3.3V$	2.1		3.6	
V _{IHSMB}	SMBus Input High Voltage	SMBus, V _{DDSMB} < 3.3V	0.65* V _{DDSMB}	_	_	V
V _{ILSMB} SMBus Input Low Voltage	SMBus, V _{DDSMB} = 3.3V	_	_	0.8	v	
	SMBus, V _{DDSMB} < 3.3V	_	_	0.8	V	
I _{SMBSINK}	SMBus Sink Current	SMBus, at V _{OLSMB}	4	_	_	mA
VOLSMB	SMBus Output Low Voltage	SMBus, at I _{SMBSINK}	_	_	0.4	V
f _{MAXSMB}	SMBus Operating Frequency	Maximum frequency	_	_	500	kHz
t _{RMSB}	SMBus Rise Time	(Max V _{IL} - 0.15) to (Min V _{IH} + 0.15)	_	_	1000	ns
t _{FMSB}	SMBus Fall Time	(Min V_{IH} + 0.15) to (Max V_{IL} - 0.15)	_	_	300	ns

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LVCMOS DC Electrical Characteristics

Temperature = T_A; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
V _{IH}	Input High Voltage	Single-ended inputs, except SMBus	0.75* V _{DD}	_	V _{DD} +0.3	V
V _{IM}	Input Mid Voltage	SADR0_TRI, SADR1_TRI, BW_SEL_TRI	$0.4 V_{DD}$	$0.5 V_{DD}$	$0.6V_{\rm DD}$	V
V _{IL}	Input Low Voltage	Single-ended inputs, except SMBus	-0.3	_	0.25 V _{DD}	V
I _{IH}	Input High Current	Single-ended inputs, $V_{IN} = V_{DD}$		_	5	μΑ
I _{IL}	Input Low Current	Single-ended inputs, $V_{IN} = 0V$	-5	—		μΑ
I _{IH}	Input High Current	Single-ended inputs with pullup/pulldown resistor, $V_{IN} = V_{DD}$	_	_	50	μΑ
I _{IL}	Input Low Current	Single-ended inputs with pullup/pulldown resistor, $V_{\rm IN}$ = 0V	-50	_	_	μΑ
C _{IN}	Input Capacitance	_	1.5	_	5	pF

LVCMOS AC Electrical Characteristics

Temperature = T_A; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Min.	Тур.	Max.	Units	
t _{OELAT}	Output Enable Latency	Q start after OE# assertion Q stop after OE# deassertion	4	5	10	clocks
t _{PDLAT}	PD# Deassertion	Differential outputs enable after PD# deassertion	_	20	300	μs





HCSL Input Characteristics⁽¹⁾

Temperature = T _A ; Supply voltages per normal operation conditions; See test circuits for the load conditions Symbol Parameters Conditions Min											
Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units					
V _{IHDIF}	Diff. Input High Voltage ⁽³⁾	IN+, IN-, single-end measurement	600	800	1150	mV					
V _{ILDIF}	Diff. Input Low Voltage ⁽³⁾	IN+, IN-, single-end measurement	-300	0	300	mV					
V _{COM}	Diff. Input Common Mode Voltage		150	_	900	mV					
V _{SWING}	Diff. Input Swing Voltage	Peak to peak value (V_{IHDIF} - V_{ILDIF})	300		2900	mV					
f _{INBP}	Input Frequency	PLL Bypass mode	1		400	MHz					
f _{IN100}	Input Frequency	100MHz PLL	98.5	100	102.5	MHz					
f _{IN133}	Input Frequency	133MHz PLL	132	133.33	135	MHz					
f _{MODI-} PCIe	Input SS Modulation Freq. PCIe	Allowable frequency for PCIe applications (Triangular Modulation)	30	_	33	kHz					
t _{STAB}	Clock stabilization	From V _{DD} Power-Up and after input clock stabilization or de-assertion of PD# to 1st clock	_	0.75	1.0	ms					
t _{RF}	Diff. Input Slew Rate ⁽²⁾	Measured differentially with 10 inch trace. Please refer to test load Figure 1	0.4	_	_	V/ns					
I _{IN}	Diff. Input Leakage Current	$V_{IN} = V_{DD}, V_{IN} = GND$	-5	0.01	5	uA					
t _{DC}	Diff. Input Duty Cycle	Measured differentially	45		55	%					
tj _{c-c}	Diff. Input Cycle to cycle jitter	Measured differentially			125	ps					

Note:

1. Guaranteed by design and characterization, not 100% tested in production

2. Slew rate measured through +/-75mV window centered around differential zero

3. The device can be driven by a single-ended clock by driving the true clock and biasing the complement clock input to the Vbias, where Vbias is (VIH-VIL)/2

HCSL Output DC Characteristics

Temperature = T_A; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Condition	Min.	Тур.	Max.	Units
V _{OH}	Output Voltage High ⁽¹⁾	Statistical measurement on single-ended	660	—	850	mV
VOL	Output Voltage Low ⁽¹⁾	signal using oscilloscope math function	-150		150	mV
V _{OMAX}	Output Voltage Maximum ⁽¹⁾	Measurement on single ended signal using	_		1150	mV
V _{OMIN}	Output Voltage Minimum ⁽¹⁾	absolute value	-300		_	mV
V _{OC}	Output Cross Voltage ^(1,2,4)	_	250		550	mV
DV _{OC}	V _{OC} Magnitude Change ^(1,2,5)	_	_		140	mV

Note:

1. At default SMBUS amplitude settings.

2. Guaranteed by design and characterization-not 100% tested in production.

3. Measured from differential waveform.

4. This one is defined as voltage where Q + = Q- measured on a component test board and only applied to the differential rising edge.

5. The total variation of all Vcross measurements in any particular system. This is a subset of Vcross_min/max allowed.





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HCSL Output AC Characteristics

		mal operation conditions; See test circuits for th				
Symbol	Parameters	Condition	Min.	Тур.	Max.	Units
f	Output Frequency	PLL mode 100MHz	98.5	100	102.5	MHz
fout	Output Frequency	PLL bypass mode	1	_	400	MHz
BW	PLL Bandwidth ^(1,8)	-3dB point in High Bandwidth Mode	2	2.65	4	MHz
DVV	PLL Dandwidth (77	-3dB point in Low Bandwidth Mode	0.7	1.1	1.4	MHz
4:		Peak pass band gain, low bandwidth	0	1.2	2	dB
tj _{peak}	PLL Jitter Peaking	Peak pass band gain, high bandwidth	0	1.2	2.5	dB
t _{RF}	Slew Rate ^(1,2,3)	Scope averaging on fast setting with 10 inch trace. Please refer to test load Figure 1	2.2	3	4.0	V/ns
Dt _{RF}	Slew Rate Matching ^(1,2,4)	Scope averaging on	_	8	20	%
t _{SKEW}	Output Skew ^(1,2)	Averaging on, $V_T = 50\%$	_	30	50	ps
t _{DC}	Duty Cycle ^(1,2)	Measured differentially, PLL Mode	45	50	55	%
t _{DCD}	Duty Cycle Distortion ^(1,7)	Measured differentially, PLL Bypass Mode at 100MHz	-3.5	0	3.5	%
		PLL mode	_	14	50	ps
tj _{c-c}	Cycle-to-Cycle Jitter ^(1,2)	Additive jitter, Bypass mode	_	0.1	1	ps
t _{pd_PLL}	Propagation delay	Input to output propagation delay in PLL mode at 100MHz with nominal tempera- ture and voltage	-100	15	100	ps
t _{pd_BYP}	Propagation delay	Input to output propagation delay in ByPass mode at 100MHz with nominal temperature and voltage	1650	2150	2650	ps





HCSL Output AC Characteristics (PLL Mode PCIe Phase Jitter)

Symbol	Parameters	Condition	Min.	Тур.	Max.	Spec Limit	Units
		PCIe 1.0 ⁽⁶⁾	_	2.5	5	86	ps (p-p)
		PCIe 2.0 Low Band	_	0.025	0.05	3.1	ps
	Integrated Phase Jitter PLL Mode (RMS) ^(1,5)	PCIe 2.0 High Band	_	0.161	0.18	3	ps
tj _{PH_PLL_} CC	Low Bandwidth (Common	PCIe 3.0	_	0.051	0.071	1	ps
	Clocked Architecture)	PCIe 4.0	_	0.051	0.071	0.5	ps
		PCIe 5.0 ⁽¹¹⁾	_	0.02	0.026	0.15	ps
		PCIe 1.0	_	7.8	8.7		ps (p-p)
	Integrated Phase Jitter PLL	PCIe 2.0	_	0.139	0.208	_	ps
tj _{PH_PLL_} SRIS	Mode (RMS) ^(1,5) Low Bandwidth (SRIS	PCIe 3.0	_	0.061	0.12	_	ps
5K15	Architecture)	PCIe 4.0		0.062	0.12	_	ps
		PCIe 5.0 ⁽¹¹⁾	_	0.016	0.032	_	ps
		PCIe 1.0 ⁽⁶⁾	_	5.1	6.5	86	ps (p-p)
	Integrated Phase Jitter PLL	PCIe 2.0 Low Band	_	0.026	0.052	3.1	ps
tj _{PH_PLL_}	Mode (RMS) ^(1,5) High Bandwidth	PCIe 2.0 High Band	_	0.18	0.24	3	ps
CC	(Common Clocked	PCIe 3.0	_	0.053	0.063	1	ps
	Architecture)	PCIe 4.0	_	0.053	0.063	0.5	ps
		PCIe 5.0 ⁽¹¹⁾	_	0.021	0.031	0.15	ps
		PCIe 1.0	_	7.51	8.12	_	ps (p-p)
	Integrated Phase Jitter PLL Mode (RMS) ^(1,5)	PCIe 2.0	_	0.153	0.198	_	ps
tj _{PH_PLL_} SRIS	High Bandwidth	PCIe 3.0	_	0.067	0.087	_	ps
3813	(SRIS Architecture)	PCIe 4.0	_	0.07	0.09	_	ps
	, , ,	PCIe 5.0 ⁽¹¹⁾	_	0.014	0.028	_	ps

Note:

1. Guaranteed by design and characterization—not 100% tested in production.

2. Measured from differential waveform.

3. Slew rate is measured through the Vswing voltage range centered around differential 0V, within ±150mV window.

4. Slew rate matching is measured through ± 75 mV window centered around differential zero.

5. See http://www.pcisig.com for complete specs.

6. Sample size of at least 100k cycles. This can be extrapolated to 108ps pk-pk @ 1M cycles for a BER of 10^{-12} .

7. Duty cycle distortion is the difference in duty cycle between the output and input clock when the device is operated in the PLL bypass mode.

8. The Min and Max values of each BW setting track each other, low BW max will never occur with high BW min.

9. Applies to all differential outputs.

10. For additive jitter RMS value is calculated by the following equation = SQRT [(total jitter)² - (input jitter)²].

11. PCIe 5.0 v0.9 specification.





HCSL Output AC Characteristics (Fanout Buffer Mode Additive Phase Jitter)

Symbol	Parameters	Condition	Min.	Тур.	Max.	Output Limit	Units
		PCIe 1.0 ⁽⁶⁾	_	1.2	1.8	86	ps (p-p)
		PCIe 2.0 Low Band	_	0.004	0.015	3	ps
43	Additive Integrated Phase Jitter (RMS) ^(1,5) (Common Clocked Architecture)	PCIe 2.0 High Band	_	0.058	0.087	3.1	ps
tjph_a_cc		PCIe 3.0	_	0.019	0.0228	1	ps
		PCIe 4.0	_	0.019	0.0228	0.5	ps
		PCIe 5.0 ⁽¹¹⁾	_	0.0074	0.0174	0.15	ps
		PCIe 1.0	_	0.111	0.154	_	ps (p-p)
	Additive Integrated Phase Jitter	PCIe 2.0	_	0.051	0.09		ps
tj _{PH_A_SRIS}	(RMS) ^(1,5,10)	PCIe 3.0	_	0.022	0.042		ps
	(SRIS Architecture)	PCIe 4.0	_	0.023	0.043	_	ps
		PCIe 5.0 ⁽¹¹⁾	_	0.006	0.026	_	ps
tj _{PH_A_12k-} 20M	Additive Integrated Phase Jitter (RMS) ^(1,5,10) 12kHz ~ 20MHz	100MHz, SSC off	_	0.086	0.111		ps

Note:

1. Guaranteed by design and characterization-not 100% tested in production.

2. Measured from differential waveform.

3. Slew rate is measured through the Vswing voltage range centered around differential 0V, within ±150mV window.

4. Slew rate matching is measured through ±75mV window centered around differential zero.

5. See http://www.pcisig.com for complete specs.

6. Sample size of at least 100k cycles. This can be extrapolated to 108ps pk-pk @ 1M cycles for a BER of 10⁻¹².

7. Duty cycle distortion is the difference in duty cycle between the output and input clock when the device is operated in the PLL bypass mode.

8. The Min and Max values of each BW setting track each other, low BW max will never occur with high BW min.

9. Applies to all differential outputs.

10. For additive jitter RMS value is calculated by the following equation = SQRT [(total jitter)^{*2} - (input jitter)^{*2}].

11. PCIe 5.0 v0.9 specification.





HCSL Output Filtered Phase Jitter (QPI_UPI/DB2000Q)

Symbol	Parameters	Condition	Min.	Тур.	Max.	Spec Limit	Units
		QPI and UPI, 100M or 133.33MHz, 4.8Gbps, 6.4Gbps 12UI	_	0.18	0.38	0.5	ps
tj _{PHPLL}	Integrated Phase Jitter PLL Mode (RMS) ^(1,5)	QPI and UPI, 100MHz, 8.0Gbps, 12UI	_	0.17	0.2	0.3	ps
QPI_UPI		QPI and UPI, 100MHz, <11.4Gbps, 12UI	_	0.14	0.16	0.2	ps
	Fanout Buffer Mode	QPI and UPI, 100M or 133.33MHz, 4.8Gbps, 6.4Gbps 12UI	_	0.06	0.08	_	ps (p-p)
tj _{PH_QPI_}	Additive Integrated Phase	QPI and UPI, 100MHz, 8.0Gbps, 12UI	_	0.06	0.08	_	ps
UPI	Jitter (RMS) ^(1,5,10)	QPI and UPI, 100MHz, <11.4Gbps, 12UI	_	0.03	0.06	_	ps
	PLL Mode IF-UPI phase	Low bandwidth	_	0.15	0.18	1	ps
tjph_ifupi	jitter	High bandwidth	_	0.18	0.22	1	ps
9PH_IFOPI	Fanout Buffer Mode IF- UPI phase jitter		_	0.08	0.1	1	ps
tj _{PH_} DB2000Q	Fanout Buffer Mode DB2000Q phase jitter			0.02	0.03	0.08	ps

Note:

1. Guaranteed by design and characterization-not 100% tested in production.

2. Measured from differential waveform.

3. Slew rate is measured through the Vswing voltage range centered around differential 0V, within ±150mV window.

4. Slew rate matching is measured through ±75mV window centered around differential zero.

5. See http://www.pcisig.com for complete specs.

6. Sample size of at least 100k cycles. This can be extrapolated to 108ps pk-pk @ 1M cycles for a BER of 10^{-12} .

7. Duty cycle distortion is the difference in duty cycle between the output and input clock when the device is operated in the PLL bypass mode.

8. The Min and Max values of each BW setting track each other, low BW max will never occur with high BW min.

9. Applies to all differential outputs.

10. For additive jitter RMS value is calculated by the following equation = SQRT [(total jitter)^{*2} - (input jitter)^{*2}].

11. PCIe 5.0 v0.9 specification.





SMBus Serial Data Interface

PI6CBE33125 is a slave-only device that supports block read and block write protocol using a single 7-bit address and read/write bit as shown below.

Read and write block transfers can be stopped after any complete byte transfer.

Address Assignment

A6	A5	A4	A3	A2	A1	A0	R/W
1	1	0	See SMBus Add	See SMBus Address Selection table			

Note: SMBus address is latched on SADR pin

How to Write

1 bit	7 bits	1 bit	1 bit	8 bits	1 bit	8 bits	1 bit	8 bits	1 bit	8 bits	1 bit	1 bit
Start bit	Add.	W(0)	Ack	Beginning Byte loca- tion = N	Ack	Data Byte count = X	Ack	Beginning Data Byte (N)	Ack	 Data Byte (N+X-1)	Ack	Stop bit

How to Read

1 bit	7 bits	1 bit	1 bit	8 bits	1 bit	1 bit	7 bits	1 bit	1 bit	8 bits	1 bit	8 bits	1 bit
Start bit	Address	W(0)	Ack	Beginning Byte loca- tion = N	Ack	Repeat Start bit	Address	R(1)	Ack	Data Byte count = X	Ack	Beginning Data Byte (N)	Ack

8 bits	1 bit	1 bit
Data Byte	NAck	Stop bit
(N+X-1)	INACK	Stop bit





Byte 0: PLL Operating Mode and Frequency Select Register

Bit	Control Function	Description	Туре	Power-up Condition	0	1
7	PLLMODERB1	PLL Mode Readback Bit1	R	Latch	00 = Low BW	ZDB
					01= Fanout me	ode
6	PLLMODERB0	PLL Mode Readback Bit0	R	Latch	10 = Reserved	
					11 = High BW ZDB	
5	Reserved	_		0	_	_
4	Reserved	_		0	_	_
3	PLL SW Control	PLL Mode control Bit0	RW ⁽¹⁾	0	Hardware Latch	SMBus Con- trol
2	PLL mode	PLL Mode 1	RW	1	00 = Low BW	ZDB
					01= Fanout mode	
1	PLL mode	PLL Mode 0	RW	1	10 = Reserved 11 = High BW ZDB	
0	Frequency Select RB	Frequency select readback	R	Latch	133MHz	100MHz

Byte 1: Output Enable Register 1

Bit	Control Function	Description	Туре	Power-up Condition	0	1
7	Q7_OE	Q7 output enable	RW	1	Output Low/ Low	OE Pin Control
6	Q6_OE	Q6 output enable	RW	1	Output Low/ Low	OE Pin Control
5	Q5_OE	Q5 output enable	RW	1	Output Low/ Low	OE Pin Control
4	Q4_OE	Q4 output enable	RW	1	Output Low/ Low	OE Pin Control
3	Q3_OE	Q3 output enable	RW	1	Output Low/ Low	OE Pin Control
2	Q2_OE	Q2 output enable	RW	1	Output Low/ Low	OE Pin Control
1	Q1_OE	Q1 output enable	RW	1	Output Low/ Low	OE Pin Control
0	Q0_OE	Q0 output enable	RW	1	Output Low/ Low	OE Pin Control





Byte 2: Output Enable Register 2

Bit	Control Function	Description	Туре	Power-up Condition	0	1
7	Reserved	—	RW	0	—	—
6	Reserved	—	RW	0		_
5	Reserved	—	RW	0		_
4	Reserved	_	RW	0	_	_
3	Q11_OE	Q11 output enable	RW	1	Output Low/ Low	OE Pin Control
2	Q10_OE	Q10 output enable	RW	1	Output Low/ Low	OE Pin Control
1	Q9_OE	Q9 output enable	RW	1	Output Low/ Low	OE Pin Control
0	Q8_OE	Q8 output enable	RW	1	Output Low/ Low	OE Pin Control

Byte 3 and Byte 4: Reserved

Byte 5: Revision and Vendor ID Register

Bit	Control Function	Description	Туре	Power-up Condition	0	1	
7	RID3		R	0	rev = 0000		
6	RID2	Revision ID	R	0			
5	RID1		R	0			
4	RID0		R	0			
3	PVID3		R	0			
2	PVID2		R	0	Diodes = 0011		
1	PVID1	Vendor ID	R	1			
0	PVID0		R	1			





Byte 6: Device ID Register

Bit	Control Function	Description	Туре	Power-up Condition
7		DID7	R	
6		DID6	R	
5		DID5	R	
4	NI A	DID4	R	0hB7 for PI6CBE33125
3	NA	DID3	R	UID/ IOF PI6CDE35125
2		DID2	R	
1		DID1	R	
0		DID0	R	

Byte 7: Byte Count Register

Bit	Control Function	Description	Туре	Power-up Condition	0	1
7	Reserved	—		0	—	_
6	Reserved	—		0		_
5	Reserved	—		0	_	_
4	BC4		RW	0		_
3	BC3		RW	1		_
2	BC2	Wring to the register configures how many bytes will be read back on a block read	RW	0	—	_
1	BC1	bytes will be read back off a brock read	RW	0		_
0	BC0		RW	0	_	_





Test Loads



Figure 1. Low-Power HCSL Test Circuit"



Figure 2. Test Set Up for Phase Jitter Measurement

LVDS Output Termination Table

Component	Receiver with Termination	Receiver without Termination	Unit
R_{1a}, R_{1b}	10,000	130	Ω
R _{2a} , R _{2b}	5600	64	Ω
C _C	0.1	0.1	μF
V _{CM}	1.2	1.2	V





LVDS Output Termination



Figure 3. Differential Output Driving LVDS

Power Supply



Figure 4. Power Supply Filter

Thermal Characteristics Table

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
θ_{JA}	Thermal Resistance Junction to Ambient	Still air		19.8		°C/W
θ_{JC}	Thermal Resistance Junction to Case			8.3		°C/W

Part Marking





Packaging Mechanical

64-TQFN (ZD)



For latest package information:

See http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/.





Ordering Information

Ordering Code	Package Code	Package Description	Temperature	Pin 1 Orientation
PI6CBE33125ZDIEX	ZD	64-Contact, Very Thin Quad Flat No-Lead (TQFN)	-40~85°C	Top Right Corner
PI6CBE33125ZDIEX-13R	ZD	64-Contact, Very Thin Quad Flat No-Lead (TQFN)	-40~85°C	Top Left Corner

Notes:

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free. 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. I = Industrial
- 5. E = Pb-free and Green
- 6. X suffix = Tape/Reel
- 7. For packaging detail, go to our website at: https://www.diodes.com/assets/MediaList-Attachments/Diodes-Package-Information.pdf

Pin 1 Orientation







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